


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590064	<b>Applicant(s)/Patent Under Reexamination</b>  OKUYAMA ET AL.
	<b>Examiner</b>  Jafar Parsa	<b>Art Unit</b>  1621

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
564	154, 156	2/9/09	jp

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STN AND EAST	2/9/09	JP
INVENTOR NAME SEARCH	2/9/09	JP

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

--	--